

Notice of References Cited	Application/Control No. 10/523,234	Applicant(s)/Patent Under Reexamination NAKAMURA ET AL.	
	Examiner Nicholas S. Ulrich	Art Unit 2173	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0101203 A1	05-2003	Chen et al.	707/513
*	B	US-6,125,204	09-2000	Nakatsuka et al.	382/173
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
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FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

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